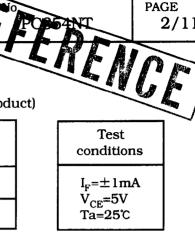


Refer to the attached sheet, page 9 to 11.

e	5.3 Collector ("〇" mar	current (Ic) Deliver k : indicates busine	ry rank table ss dealing name of	f ordered produ	ıct)
	Rank at delivery	Business dealing name	Rank mark	Ic (mA)	
	0	PC354NT	A or no mark	0.2 to 4.0	
		PC354N1T	A	0.5 to 1.5	



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6.4 This Model is approved by UL.

Approved Model No. : PC354

UL file No. : E64380

- 6.5 This product is AC input type.
- 6.6 This product is not designed against irradiation.

This product is operated with electrical input and output.

This product incorporates non-coherent light emitting diode.

6.7 ODS materials

This product shall not contain the following materials. Also, the following materials shall not be used in the production process for this product.

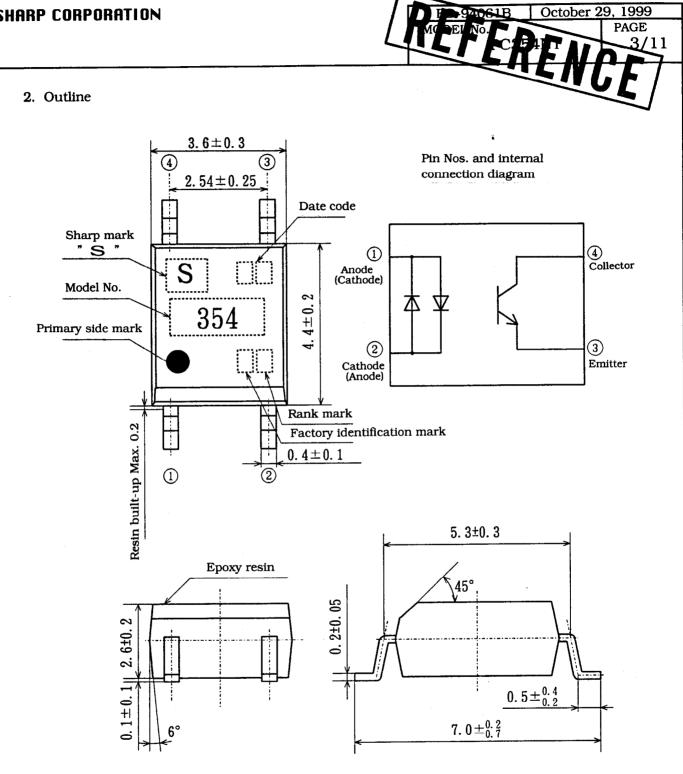
Materials for ODS : CFC<sub>s</sub>, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

6.8 Brominated flame retardants

Specific brominated flame retardants such as the PBBO<sub>S</sub> and PBB<sub>S</sub> are not used in this device at all.

7. Notes

Refer to the attached sheet-1-1, 2.



- \*1) 2-digit number shall be marked according to DIN standard.
- \*2) Factory identification mark shall be or shall not be marked.
- \*3) Rank mark : "A" or no mark
- \*4) Marking is laser marking

Product mass : Approx. 0.1g

	UNIT : 1/1 mm
Name	PC354 Outline Dimensions (Business dealing name : PC354NT)

- 3. Ratings and characteristics
  - 3.1 Absolute maximum ratings

Parameter	Symbol	Rating	Unit
*1 Forward current	I <sub>F</sub>	$\pm 50$	mA
*2 Peak forward current	I <sub>FM</sub>	±1	А
*1 Power dissipation	Р	70	mW
Collector-emitter voltage	V <sub>CEO</sub>	35	v
Emitter-collector voltage	V <sub>ECO</sub>	6	v
Collector current	Ic	50	mA
*1 Collector power dissipation	Pc	150	mW
*1 Total power dissipation	Ptot	170	mW
Operating temperature	Topr	-30 to +100	Ĵ
Storage temperature	Tstg	-40 to +125	Ĵ
*3 Isolation voltage	Viso(rms)	3.75	kV
*4 Soldering temperature	Tsol	260	ç
	<ul> <li>*1 Forward current</li> <li>*2 Peak forward current</li> <li>*1 Power dissipation</li> <li>Collector-emitter voltage</li> <li>Emitter-collector voltage</li> <li>Collector current</li> <li>*1 Collector power dissipation</li> <li>*1 Total power dissipation</li> <li>Operating temperature</li> <li>Storage temperature</li> <li>*3 Isolation voltage</li> </ul>	*1 Forward currentIF*2 Peak forward currentIFM*1 Power dissipationPCollector-emitter voltageVCEOEmitter-collector voltageVECOCollector currentIc*1 Collector power dissipationPc*1 Total power dissipationPtotOperating temperatureToprStorage temperatureTstg*3 Isolation voltageViso(rms)	*1 Forward current $I_F$ $\pm 50$ *2 Peak forward current $I_{FM}$ $\pm 1$ *1 Power dissipationP70Collector-emitter voltage $V_{CEO}$ 35Emitter-collector voltage $V_{ECO}$ 6Collector currentIc50*1 Collector power dissipationPc150*1 Collector power dissipationPtot170Operating temperatureTopr-30 to +100Storage temperatureTstg-40 to +125*3 Isolation voltageViso(rms)3.75

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\*1 The derating factors of absolute maximum ratings due to ambient temperature are shown in Fig. 1 to 4.

- \*2 Pulse width  $\leq 100 \,\mu$ s, Duty ratio : 0.001 (Refer to Fig. 5)
- \*3 AC for 1 min, 40 to 60%RH, f=60Hz

\*4 For 10 s

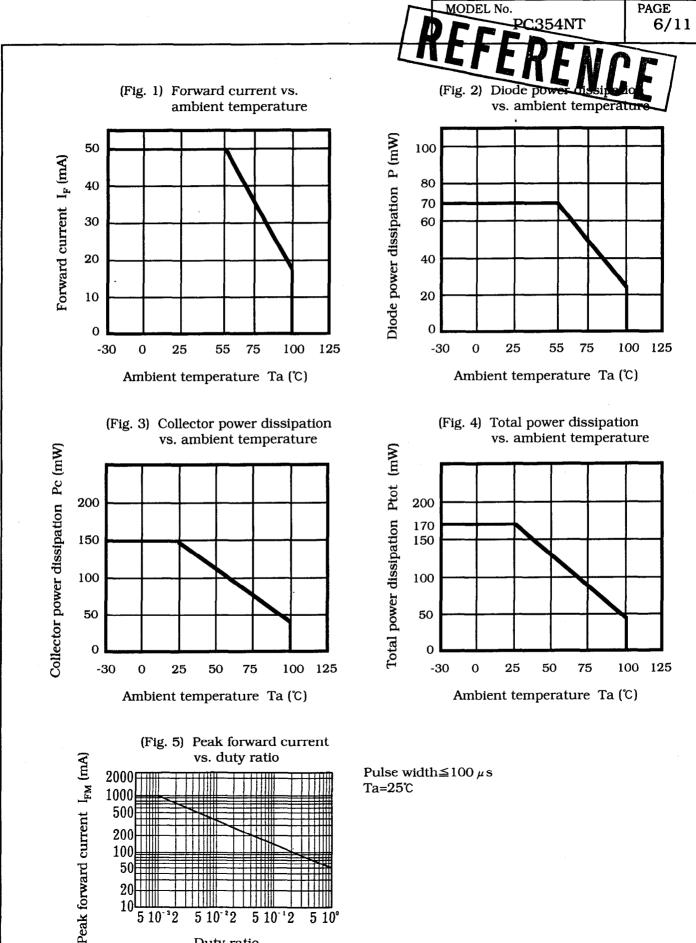
#### 3.2 Electro-optical characteristics

					EL No.	354N	Г	PAGE 5/11
3.2 Elec	etro-optical charac	eteristic	s		<u>r</u> E	RE	Ta=25	
	Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Innet	Forward voltage	e	V <sub>F</sub>	I <sub>F</sub> =±20mA	-	1.2	1.4	v
Input	Terminal capac	itance	Ct	V=0, f=1kHz	-	30	250	pF
	Dark current		I <sub>CEO</sub>	V <sub>CE</sub> =20V, I <sub>F</sub> =0	-	-	100	nA
Output	Collector-emitter breakdown voltage		BV <sub>CEO</sub>	Ic=0.1mA I <sub>F</sub> =0	35	-	-	v
	Emitter-collector breakdown voltage		BV <sub>ECO</sub>	$I_{E} = 10 \ \mu A, \ I_{F} = 0$	6	-	-	v
	Collector currer	nt	Ic	$I_F = \pm 1 \text{mA}, V_{CE} = 5 \text{V}$	0.2	-	4.0	mA
	Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	I <sub>F</sub> =±20mA Ic=1mA	-	0.1	0.2	v
Transfer charac-	Isolation resistance		Riso	DC500V 40 to 60%RH	5×10 <sup>10</sup>	1011	-	Ω
teristics	Floating capaci	tance	Cf	V=0, f=1MHz	-	0.6	1.0	pF
	Response time	Rise	tr	V <sub>CE</sub> =2V Ic=2mA	-	4	18	μs
	Response time	Fall	tſ	$R_{L} = 100 \Omega$	-	3	18	μs

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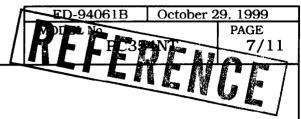
Duty ratio

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4. Reliability

The reliability of products shall satisfy items listed below.

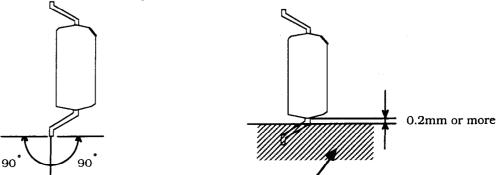


Confidence level : 90% LTPD : 10%/20%

Test Items	Test Conditions *1	Failure Judgement Criteria	Samples (n) Defective(C)
Solderability *2	230°C, 5 s		n=11, C=0
Soldering heat *3	260°C, 10 s		n=11, C=0
Terminal strength (Bending) *4	Weight : 1N 1 time/each terminal	$V_{\rm F}>U\times1.2$	n=11, C=0
Mechanical shock	$15000 \text{m/s}^2$ , 0.5ms 3 times/±X, ±Y, ±Z direction	I <sub>CEO</sub> >U×2 I <sub>C</sub> <l×0.7< td=""><td>n=11, C<b>=</b>0</td></l×0.7<>	n=11, C <b>=</b> 0
Variable frequency vibration	100 to 2000 to 100Hz/4min 200m/s <sup>2</sup> 4 times/ X, Y, Z direction	$V_{CE(sat)}$ >U×1.2	n=11, C <b>=0</b>
Temperature cycling	1 cycle -40°C to +125°C (30min) (30min) 20 cycles test		n=22,C=0
High temp. and high humidity storage *5	+85°C, 85%RH, 500h	U : Upper specification limit	n=22,C=0
High temp. storage	+125°C, 1000h	L : Lower specification	n=22,C=0
Low temp. storage	-40°C, 1000h	limit	n=22,C=0
Operation life	I <sub>F</sub> =±50mA, Ptot=170mW Ta=25℃, 1000h		n=22,C=0

\*1 Test method, conforms to EIAJ ED 4701.

- \*2 Solder shall adhere at the area of 95% or more of immersed portion of lead, and pin hole or other holes shall not be concentrated on one portion.
- \*3 The lead pin depth dipped into solder shall be 0.2mm away from the root of lead pins.
- \*4 Terminal bending direction is shown below.
- \*5 It is evaluated after washing by specified solvent in attach sheet-1-1, 2.



- 5. Incoming inspection
  - 5.1 Inspection items
  - (1) Electrical characteristics

V<sub>F</sub>, I<sub>CEO</sub>, V<sub>CE(sat)</sub>, Ic, Riso, Viso

- (2) Appearance
- 5.2 Sampling method and Inspection level

A single sampling plan, normal inspection level II based on ISO 2859 is applied. The AQL according to the inspection items are shown below.

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Defect	Inspection item	AQL (%)
Major defect	Electrical characteristics Unreadable marking	0.1
Minor defect	Appearance defect except the above mentioned.	0.4

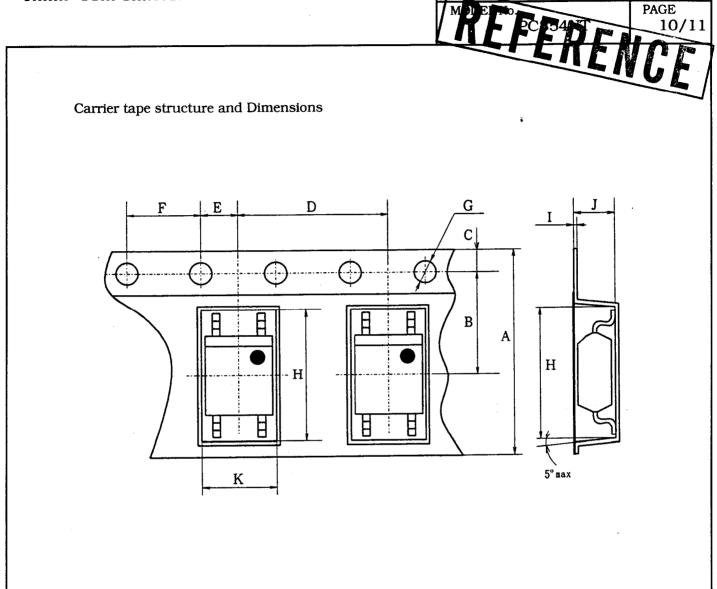
MODEL No. PAGE PC354NT 9/11
6.2 Package specifications
6.2.1 Taping conditions
(1) Tape structure and Dimensions (Refer to the attached sheet, Page 10)
The tape shall have a structure in which a cover tape is sealed heat-pressed on the carrier tape of protect against static electricity.
(2) Reel structure and Dimensions (Refer to the attached sheet, Page 11)
The taping reel shall be of plastic with its dimensions as shown in the attached drawing.
(3) Direction of product insertion (Refer to the attached sheet, Page 11)
Product direction in carrier tape shall direct to the anode mark at the hole side on the tape.
(4) Joint of tape
The cover tape and carrier tape in one reel shall be jointless.
(5) The way to repair taped failure devices
The way to repair taped failure devices cut a bottom of carrier tape with a cutter, and after replacing to good devices, the cut portion shall be sealed with adhesive tape.
6.2.2 Adhesiveness of cover tape
• The exfoliation force between carrier tape and cover tape shall be $0.2N$ to $0.7N$ for the angle from $160^\circ$ to $180^\circ$ .
6.2.3 Rolling method and quantity
• Wind the tape back on the reel so that the cover tape will be outside the tape. Attach more than 20cm of blank tape to the trailer and the leader of the tape and fix the both ends with adhesive tape. One reel shall contain 750pcs.
6.2.4 Marking
• The outer packaging case shall be marked with following information.
* Model No. * Number of pieces delivered * Production date
6.2.5 Storage condition
• Taped products shall be stored at the temperature between 5 and 30°C and the humidities lower than 70%RH.

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6.2.6 Safety protection during shipping

 $\boldsymbol{\cdot}$  There shall be no deformation of component or degradation of electrical characteristics due to shipping.

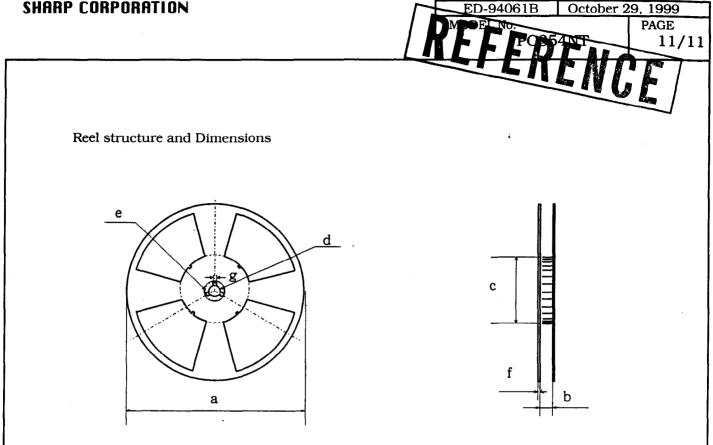


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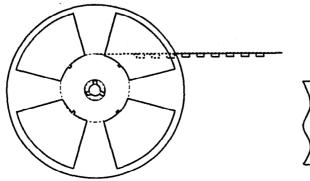
Symbol Unit	А	В	С	D	E
mm	±0.3	±0.05	±0.1	±0.1	$\pm 0.05$
	12.0	5.5	1.75	8.0	2.0

Symbol Unit	F	G	Н	Ι	J	K
mm	±0.1 4.0	+0.1 -0.0 \$\$\$	±0.1 7.4	±0.05 0.3	±0.1 <b>3.1</b>	±0.1 4.0

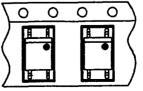


Symbol		Check word							
Unit	а	b	С	d	e	f	g		
mm	180	13.5±1.5	80±1.0	13±0.5	21±1.0	$2.0 {\pm} 0.5$	$2.0 {\pm} 0.5$		

Direction of product insertion



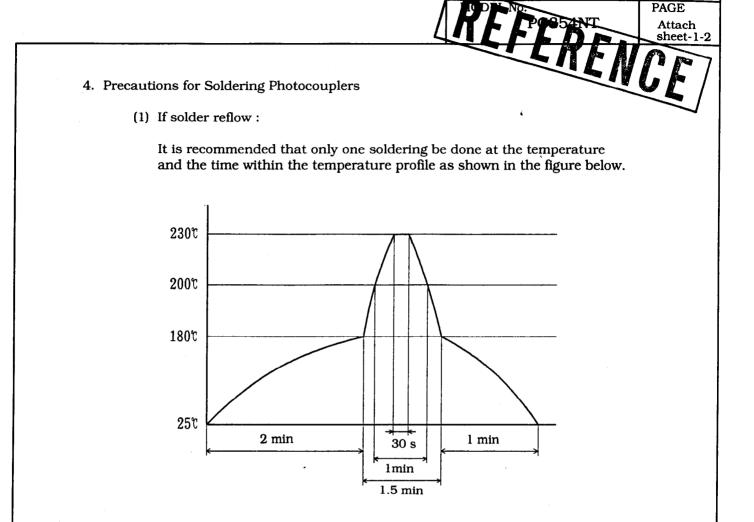
Pull-out direction



PAGE Attach Sheet-1-1
Precautions for Photocouplers
1 For cleaning
(1) Solvent cleaning : Solvent temperature 45℃ or less Immersion for 3 min or less
(2) Ultrasonic cleaning : The effect to device by ultrasonic cleaning differs by cleaning bath size, ultrasonic power output, cleaning time. PCB size or device mounting condition etc. Please test it in actual using condition and confirm that doesn't occur any defect before starting the ultrasonic cleaning.
(3) Applicable solvent : Ethyl alcohol, Methyl alcohol, Isopropyl alcohol
In case when the other solvent is used, there are cases that the packaging resin is eroded. Please use the other solvent after thorough confirmation is performed in actual using condition.
<ol> <li>The LED used in the Photocoupler generally decreases the light emission power by operation. In case of long operation time, please design the circuit with considering the degradation of the light emission power of the LED. (50%/5years)</li> </ol>
3. There are cases that the deviation of the CTR and the degradation of the light emission power

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3. There are cases that the deviation of the CTR and the degradation of the light emission power of the LED become big at IF is less than 1.0mA. Please design the circuit with considering this point.



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Since, influence to the device is different according to reflow equipment and its condition, please use the device after confirming no damage in the actual using condition.

#### (2) Other precautions

An infrared lamp used to heat up for soldering may cause a localized temperature rise in the resin. So keep the package temperature within that specified in Item (1). Also avoid immersing the resin part in the solder.